







CETECOM ICT Services

consulting - testing - certification >>>>

TEST REPORT

Test report no.: 1-2977/11-94-12-B



Testing laboratory

CETECOM ICT Services GmbH

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66117 Saarbruecken / Germany

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Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the

Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with

the registration number: D-PL-12076-01-01

Area of Testing: Radio/Satellite Communications

Applicant

Sony Ericsson Mobile Communications AB

Nya Vattentornet

22188 Lund / SWEDEN

+46 46 19 30 00 Phone:

Fax: +46 46 19 32 95

Contact: Håkan Sjöberg

e-mail: hakan.sjoberg@sonyericsson.com

Phone: +46 46 19 35 59

Manufacturer

Sony Ericsson Mobile Communications AB

Nya Vattentornet

22188 Lund / SWEDEN

Test standard/s

47 CFR Part 15 Title 47 of the Code of Federal Regulations; Chapter I

Part 15 - Radio frequency devices

Spectrum Management and Telecommunications - Radio Standards Specification RSS - 210 Issue 8

Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands):

Category I Equipment

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: GSM Mobile Phone 850/900/1800/1900; GPRS/EGPRS; UMTS

FDDI/FDDV/FDDVI/FDDIX/FDDXIX; HSPA; RFID; BT EDR; WLAN b/g/n; ANT+; GPS

Model name:

AAD-3880132-BV

FCC ID:

PY7A3880132

IC:

4170B-A3880132

Frequency [MHz]:

13.56 MHz

Technology tested:

RFID

Antenna:

Integrated loop antenna

Power Supply:

3.7 V DC by Li-polymer battery

Temperature Range:

-20°C to +50 °C

Test report authorised:

2012-02-03 Stefan Bös

Senior Testing Manager

Test performed:

2012-02-03 Andreas Luckenbill

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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In no case this test report can be considered as a Letter of Approval.

This test report is electronically signed and valid without handwritten signature. For verification of the electronical signatures, the public keys can be requested at the testing laboratory.

2.2 Application details

Date of receipt of order: 2011-10-19
Date of receipt of test item: 2011-12-16
Start of test: 2011-12-20
End of test: 2011-12-21

Person(s) present during the test: -/-

3 Test standard/s

Test standard	Date	Test standard description
47 CFR Part 15	2010-10	Title 47 of the Code of Federal Regulations; Chapter I Part 15 - Radio frequency devices
RSS - 210 Issue 8	2010-12	Spectrum Management and Telecommunications - Radio Standards Specification Low-power Licence-exempt Radiocommunication Devices (All Frequency Bands): Category I Equipment

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4 Test environment

 $\begin{array}{ccc} & & T_{nom} & +22 & ^{\circ}C \ during \ room \ temperature \ tests \\ Temperature: & T_{max} & +50 & ^{\circ}C \ during \ high \ temperature \ tests \end{array}$

T_{min} -20 °C during low temperature tests

Relative humidity content: 38 %

Barometric pressure: not relevant for this kind of testing

V_{nom} 3.7 V DC by Li-polymer battery

Power supply: $\begin{array}{cccc} V_{max} & \mbox{-/-} & V \\ V_{min} & \mbox{-/-} & V \end{array}$

5 Test item

Kind of test item	:	GSM Mobile Phone 850/900/1800/1900; GPRS/EGPRS; UMTS FDDI/FDDV/FDDVI/FDDIX/FDDXIX; HSPA; RFID; BT EDR; WLAN b/g/n; ANT+; GPS			
Type identification	:	AAD-3880132-BV			
S/N serial number	:	Rad. CB511VDZ8F; CB511VCP9N			
HW hardware status	:	AP 1.1			
SW software status	:	6.0.A.0.463 ATP R1A034			
Frequency band [MHz]	:	13.56 MHz			
Type of radio transmission :		Modulated carrier			
Use of frequency spectrum	<u>:</u>				
Channel access method	<u>: </u>	- -			
Type of modulation	:	NON			
Number of channels	:	1			
Antenna	:	Integrated loop antenna			
Power supply	:	3.7 V DC by Li-polymer battery			
Temperature range	:	-20°C to +50 °C			

6 Test laboratories sub-contracted

None

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7	Summary of measurement results					
		No deviations from the technical specifications were ascertained				
		There were deviations from the technical specifications ascertained				

TC Identifier	Description	Verdict	Remark	
RF-Testing	CFR Part 15 RSS 210, Issue 8, Annex 2.6	Passed	2012-02-03	-/-

Test Specification Clause	Test Case	Temperature Conditions	Power Source Voltages	Pass	Fail	NA	NP	Results (max.)
§ 15.35 (c)/ RSS-GEN Issue 2 Section 4.5	Timing of the transmitter (Duty cycle correction factor)	Nominal	Nominal					complies
§ 15.225 (a)/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of Fundamental	Nominal	Nominal					complies
§ 15.209/ RSS-210 Issue 8 Annex 2.6	Fieldstrength of harmonics and spurious	Nominal	Nominal	\boxtimes				complies
§ 15.225 (e)/		Nominal	Extreme	\boxtimes				
RSS-210 Issue 8 Annex 2.6	Frequency tolerance	Extreme	Nominal	\boxtimes				complies

Note: NA = Not Applicable; NP = Not Performed

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8 RF measurements

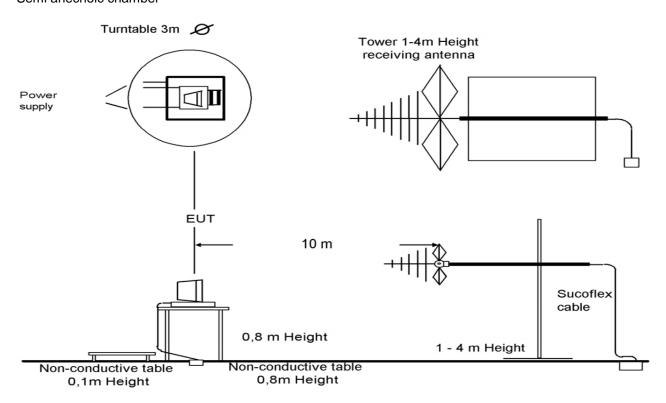
8.1 Description of test setup

8.1.1 Radiated measurements

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 25 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63.2-1996 clause 15 and ANSI C63.4-2009 clause 4.1.5. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63-4-2009 clause 4.2.

Antennas are confirmed with ANSI C63.2-1996 item 15.

Semi anechoic chamber



Picture 1: Diagram radiated measurements

9 kHz - 30 MHz: active loop antenna

30 MHz – 1 GHz: tri-log antenna

> 1 GHz: horn antenna

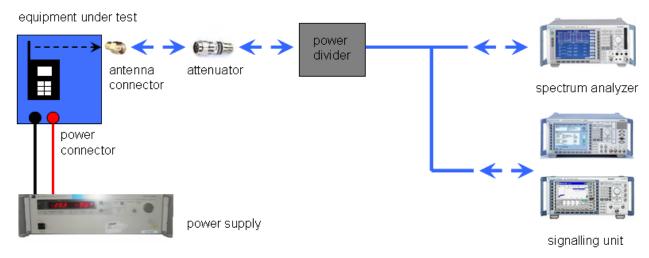
The EUT is powered by an external power supply with nominal voltage. The signalling is performed from outside the chamber with a signalling unit (CMU200 or other) by air link using signalling antenna.

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8.1.2 Conducted measurements

The EUT's RF signal is coupled out by the antenna connector which is supplied by the manufacturer. The signal is first 10dB attenuated before it is power divided (~6dB loss per branch). One of the signal paths is connected to the communication base Station (CMU200 or other), the other one is connected to the spectrum analyzer. The specific losses for both signal paths are first checked within a calibration. The measurement readings on the signalling unit/spectrum analyzer are corrected by the specific test set-up loss. The attenuator, power divider, signalling unit and the spectrum analyzer are impedance matched on 50 Ohm.



Picture 2: Diagram conducted measurements

8.2 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

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8.3 RSP100 test report cover sheet / performance test data

Test Report Number	:	1-2977/11-94-12-B
Equipment Model Number		AAD-3880132-BV
Certification Number	;	4170B-A3880132
Manufacturer (complete Address)		Sony Ericsson Mobile Communications AB Nya Vattentornet 22188 Lund / SWEDEN
Tested to radio standards specification no.	:	RSS 210, Issue 8, Annex 8
Open Area Test Site IC No.	:	IC 3462C-1
Frequency Range or fixed frequency	:	13.56 MHz
Field Strength [dBµV/m] (at which distance)	•	37 dBμV/m @10m 17 dBμV/m @30m
Occupied bandwidth (99%-BW) [Hz]		28.4
Type of modulation	:	NON
Emission Designator (TRC-43)	:	28H4N0N
Antenna Information	:	Integrated loop antenna
Transmitter Spurious (worst case) [dBµV/m @ 10m]		32 dBμV/m @ 1 GHz
Receiver Spurious (worst case) [µV/m @ 10m]	:	no idle mode

ATTESTATION: DECLARATION OF COMPLIANCE:

I attest that the testing was performed or supervised by me; that the test measurements were made in accordance with the above-mentioned Industry Canada standard(s); and that the equipment identified in this application has been subjected to all the applicable test conditions specified in the Industry Canada standards and all of the requirements of the standard have been met.

Laboratory Manager:

2012-02-03 Stefan Bös Stefan Bös



9 Measurement results

9.1 Timing of the transmitter

Measurement:

Measurement parameter				
Detector:	-/-			
Sweep time:	-/-			
Resolution bandwidth:	-/-			
Video bandwidth:	-/-			
Span:	-/-			
Trace-Mode:	-/-			

Limits:

FCC	IC			
CFR Part SUBCLAUSE § 15.35 (c)	RSS-GEN Issue 2 Section 4.5			
Timing of the transmitter				

(c) Unless otherwise specified, e.g. Section 15.255(b), when the radiated emission limits are expressed in terms of the average value of the emission, and pulsed operation is employed, the measurement field strength shall be determined by averaging over one complete pulse train, including blanking intervals, as long as the pulse train does not exceed 0.1 seconds. As an alternative (provided the transmitter operates for longer than 0.1 seconds) or in cases where the pulse train exceeds 0.1 seconds, the measured field strength shall be determined from the average absolute voltage during a 0.1 second interval during which the field strength is at its maximum value. The exact method of calculating the average field strength shall be submitted with any application for certification or shall be retained in the measurement data file for equipment subject to notification or verification.

Note:

Duty cycle 100%.

Result: The result of the measurement is passed.

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9.2 Field strength of the fundamental

Measurement:

Measurement parameter				
Detector:	Quai Peak			
Sweep time:	Auto			
Resolution bandwidth:	200 Hz up to 150 kHz, 9 kHz up to 30 MHz, 120 kHz up to 1 GHz			
Video bandwidth:	≥RBW			
Span:	10 kHz			
Trace-Mode:	Max Hold			

Limits:

FCC		IC		
CFR Part SUBCLAUSE §	15.225 (a)	RSS-210 Issue 8 Section A1.1.2 / 2.7 Table 4		
Fundamental Frequency (MHz) Field stre		f Fundamental m)	Measurement distance (m)	
13.553 to 13.567	15848 μV/m (84 dBμV/m)		30	
10.000 to 10.007	158489 μV/m (104 dBμV/m)		10	

Result:

TEST CO	NDITIONS	MAXIMUM POWER (dBμV/m)			
Freq	uency	13.56 MHz	13.56 MHz		
Mo	ode	at 10 m distance	at 30 m distance		
T _{nom}	T _{nom} V _{nom}		17.0		
Measureme	nt uncertainty	±3dB			

Result: The result of the measurement is passed.

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9.3 Field strength of the harmonics and spurious

Measurement:

Measurement parameter				
Detector:	Quasi Peak / Average			
Sweep time:	Auto			
Resolution bandwidth:	200 Hz up to 150 kHz, 9 kHz up to 30 MHz, 120 kHz up to 1 GHz			
Video bandwidth:	≥RBW			
Span:	Steps 100 MHz			
Trace-Mode:	Max Hold			

Limits:

FCC		IC			
SUBCLAUSE § 15.	.209				
Fiel	d strength of the ha	monics and spu	rious.		
Frequency (MHz)	Field strength (µV/m)		Measurement distance (m)		
0.009 - 0.490	2400/F(kHz)		300		
0.490 - 1.705	24000/F(kHz)		30		
1.705 – 30	30 (29.5 c	IBμV/m)	30		
30 – 88	100 (40 dBμV/m)		100 (40 dBμV/m)		3
88 – 216	150 (43.5	dBμV/m)	3		
216 – 960	200 (46 d	BμV/m)	3		

Result:

EMISSION LIMITATIONS								
Limit max. allowed f [MHz] Detector [dBμV/m] Amplitude of emission Results								
no d	critical emission	ons detected!						

Result: The result of the measurement is passed.

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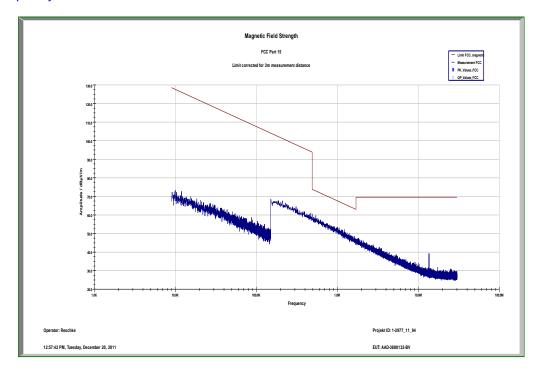


Plots of the measurements

Plot 1: 9 kHz - 30 MHz;

Part 15.209 Magnetics, Measurement distance 3m

Transmit frequency 13.56 MHz



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Plot 2: 30 MHz - 1000 MHz

Transmit frequency 13.56 MHz

Common Information

EUT: AAD-3880132-BV (2x)

Serial Number: IMEI: 00440214-460673-2 + 00440214-46172-5

Test Description: FCC part 15 B class B @ 10 m

Operating Conditions: RFID + charging
Operator Name: Hennemann
Comment: AC: 115 V / 60 Hz

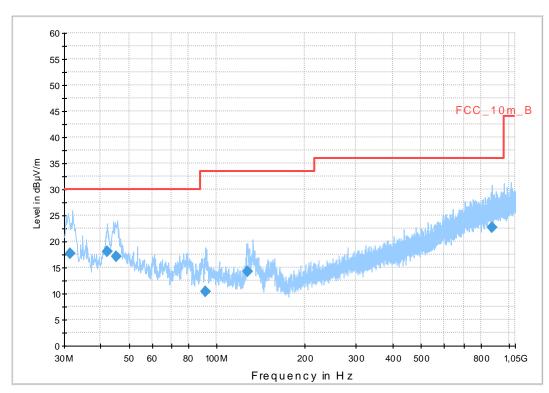
Scan Setup: STAN_Fin [EMI radiated]

Hardware Setup: Electric Field (NOS)

 $\begin{array}{lll} \text{Receiver:} & & \text{[ESCI 3]} \\ \text{Level Unit:} & & \text{dB}\mu\text{V/m} \\ \end{array}$

SubrangeStep SizeDetectorsIF BWMeas. TimePreamp30 MHz - 2 GHz60 kHzQPK120 kHz1 s20 dB

FCC_10m(B)_3



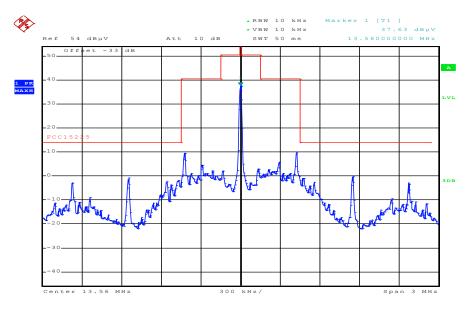
Final Result 1

mai recourt											
Frequency (MHz)	QuasiPeak (dBµV/m)	Meas. Time (ms)	Bandwidt h (kHz)	Height (cm)	Polarizatio n	Azimut h (deg)	Corr. (dB)	Margi n (dB)	Limit (dBµV/m)	Comment	
31.494750	17.7	1000.0	120.000	124.0	V	196.0	12.7	12.3	30.0		
42.012000	18.0	1000.0	120.000	105.0	V	12.0	13.4	12.0	30.0		
45.095100	17.1	1000.0	120.000	98.0	V	172.0	13.3	12.9	30.0		
91.750050	10.3	1000.0	120.000	115.0	V	196.0	10.8	23.2	33.5		
127.087200	14.3	1000.0	120.000	124.0	V	106.0	9.6	19.2	33.5		
872.768100	22.7	1000.0	120.000	170.0	V	-2.0	24.9	13.3	36.0		

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Plot 3: Spectrum mask part15.225 (a,b,c,d)



Date: 20.DEC.2011 14:21:49

Limits recalculated from 30m to 3m with 40 dB/decade according to FCC 15.31 (f2)

RBW /VBW 10 kHz

The transmitter holds the requirements of FCC 15.225 (a,b,c and d)

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9.4 Frequency tolerance

Measurement:

Measurement parameter					
Detector:	Peak				
Sweep time:	Auto				
Resolution bandwidth:	100 Hz				
Video bandwidth:	300 Hz				
Span:	30 kHz				
Trace-Mode:	Max hold				

Limits:

FCC	IC
SUBCLAUSE § 15.225	RSS-210 Issue 8 Annex 2.6

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C.

Result: The result of the measurement is passed.

	Frequency tolerance									
Over temperature variation			Over voltage variation							
Lir	mit is +/- 1.356	kHz	Limit is +/- 1.356 kHz MHz							
T (°C)]	Frequency [MHz]	result	Power voltage	I I I I I I I I I I I I I I I I I I I			Detector	Level [µV/m]		
-20°	13.560 240	Pass	98V	13.560 180	Pass					
-10°	13.560 240	Pass	104V 13.560 180		Pass					
0°	13.560 240	Pass	110V 13.560 180		Pass					
10°	13.560 180	Pass	115V 13.560 180		Pass					
20°	13.560 180	Pass	121V	21V 13.560 180						
30°	13.560 120	Pass	127V	13.560 180	Pass					
40°	13.560 000	Pass	132V	13.560 180	Pass					
50°	13.560 000	Pass								
Measure	ment uncertair	nty	±100 Hz							

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9.5 AC line conducted

Measurement:

Measurement parameter					
Detector:	Peak				
Sweep time:	Auto				
Resolution bandwidth:	200 Hz up to 150 kHz, 9 kHz up to 30 MHz 120 kHz up to 1 GHz				
Video bandwidth:	≥ RBW				
Trace-Mode:	Max hold				

Limits:

FCC	IC				
SUBCLAUSE § 15.107 / 15.207	RSS-210 Issue 8 Section 6.6, 7.4				
·					
	Conducted Limit (dBµV)				
Frequency of Emission (MHz)	Conducted Li	mit (dBµV)			
Frequency of Emission (MHz)	Conducted Li Quasi-peak	mit (dBμV) Average			
Frequency of Emission (MHz) 0.15 – 0.5					
	Quasi-peak	Average			

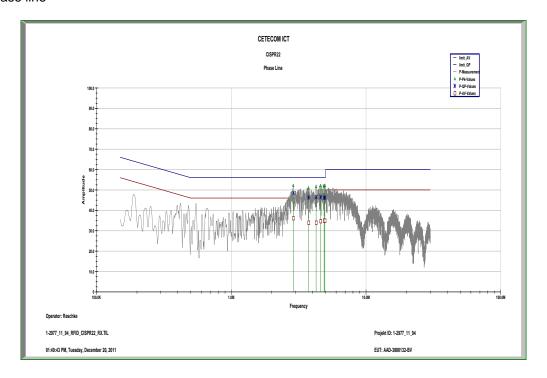
Result: The result of the measurement is passed.

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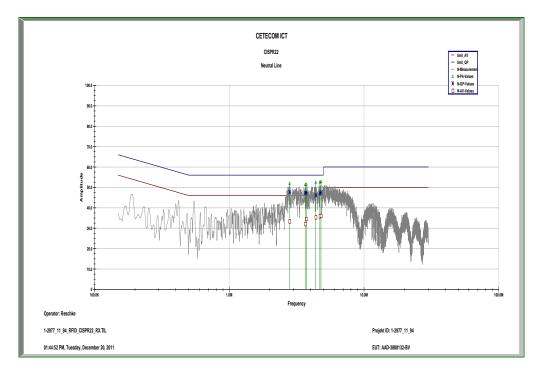


Plots:

Plot 1: Phase line



Plot 2: Neutral line



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10 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Labor/Item).

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	n. a.	Test Receiver	ESH2	R&S	871921/095	300002505	Ve	12.02.2010	12.02.2012
2	n. a.	Loop Antenna 9 KHz - 30 MHz	HFH2-Z2	R&S	872096/61	300001824	vIKI!	18.11.2008	18.03.2012
3	n. a.	Spectrum Analyzer 9kHz to 30GHz - 140+30dBm	FSP30	R&S	100886	300003575	k	07.09.2010	07.09.2012
4	n. a.	Temperature Test Chamber	VT 4002	Heraeus Voetsch	521/83761	300002326	Ve	20.09.2011	20.09.2013
5	n. a.	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	8812-3088	300001032	vIKI!	11.05.2011	11.05.2013
6	n. a.	Active Loop Antenna	6502	EMCO	2210	300001015	ne		
7	n. a.	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996		23.03.2009	
8	n. a.	Relais Matrix	3488A	HP Meßtechnik	2719A15013	300001156	ne		
9	n. a.	Switch / Control Unit	3488A	HP	2605e08770	300001443	ne		
10	n. a.	Amplifier	js42- 00502650- 28-5a	Parzich GMBH	928979	300003143	ne		
11	n. a.	TILE-Software Emission	Quantum Change, Modell TILE- ICS/FULL	EMCO	none	300003451	ne		
12	n. a.	PSA Spectrum Analyzer 3 Hz - 26.5 GHz	E4440A	Agilent Technologies	MY48250080	300003812	k	08.09.2010	08.09.2012
13	n. a.	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	371	300003854	vIKI!	14.10.2011	14.10.2014

Agenda: Kind of Calibration

k calibration / calibrated EK limited calibration

ne not required (k, ev, izw, zw not required) zw cyclical maintenance (external cyclical maintenance)

ev periodic self verification izw internal cyclical maintenance Ve long-term stability recognized g blocked for accredited testing

vlkl! Attention: extended calibration interval

NK! Attention: not calibrated *) next calibration ordered / currently in progress

11 Observations

No observations exceeding those reported with the single test cases have been made.

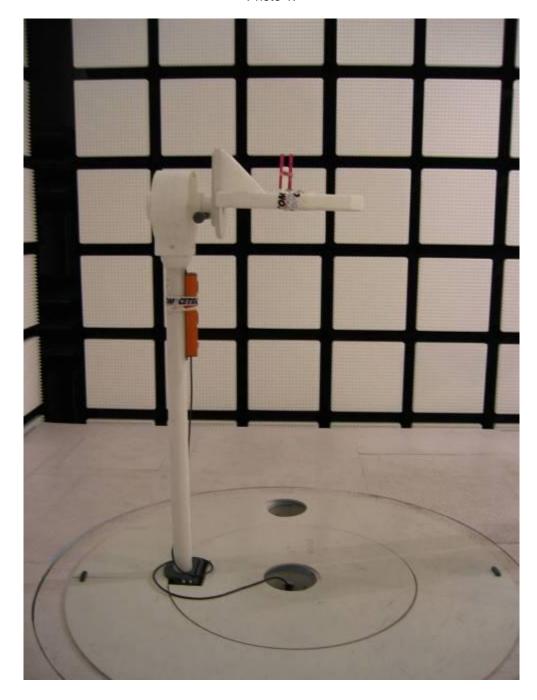
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Annex A Photographs of the test setup

Photo documentation:

Photo 1:



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Photo 2:



Photo 3:



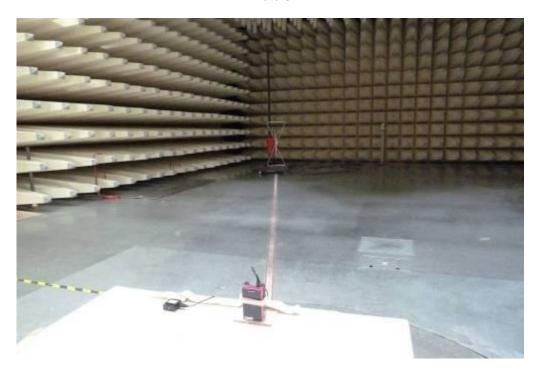
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Photo 4:



Photo 5:



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Annex B External photographs of the EUT

Photo documentation:

Photo 1:



Photo 2:



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Photo 3:



Photo 4:



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Photo 5:



Photo 6:



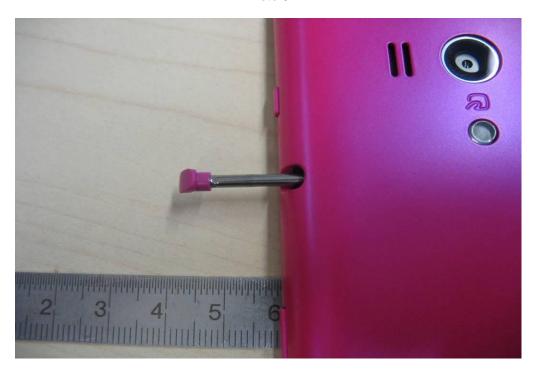
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Photo 7:



Photo 8:



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Photo 9:



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Annex C Internal photographs of the EUT

Photo documentation:

Photo 1:

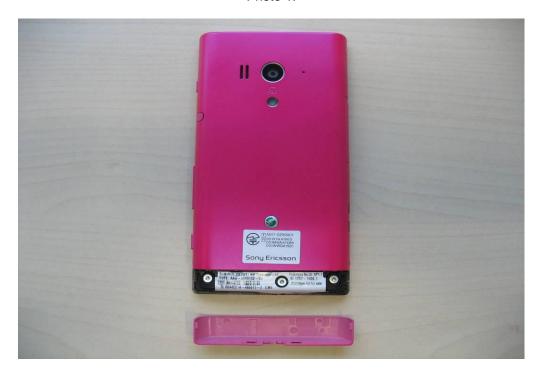


Photo 2:



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Photo 3:



Photo 4:



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Photo 5:



Photo 6:



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Photo 7:



Photo 8:



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Photo 9:

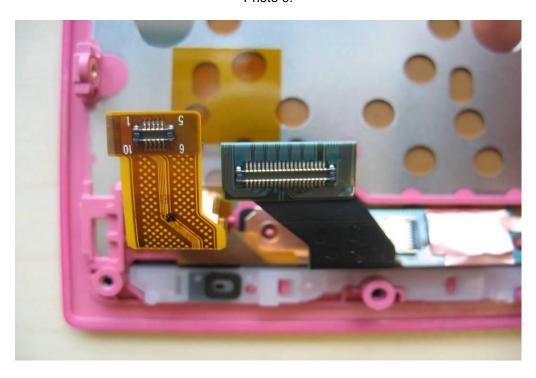


Photo 10:



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Photo 11:

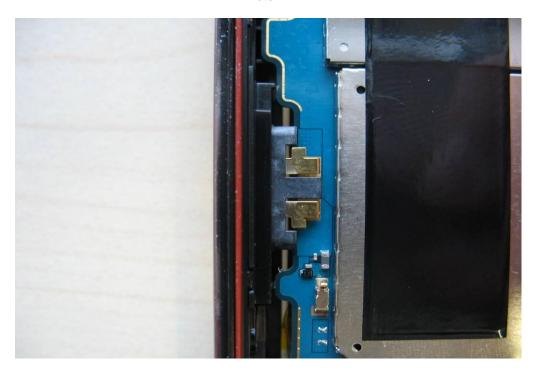
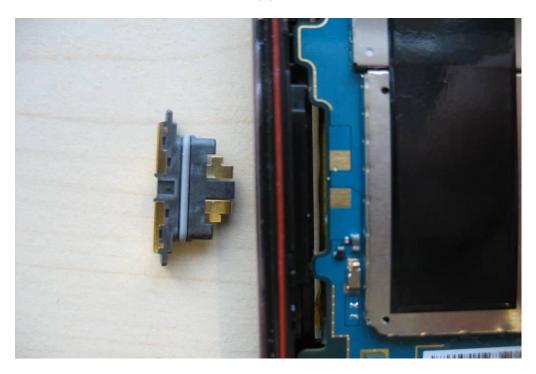


Photo 12:



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Photo 13:

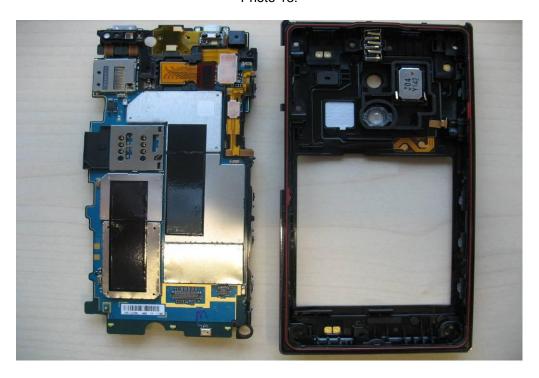


Photo 14:



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Photo 15:

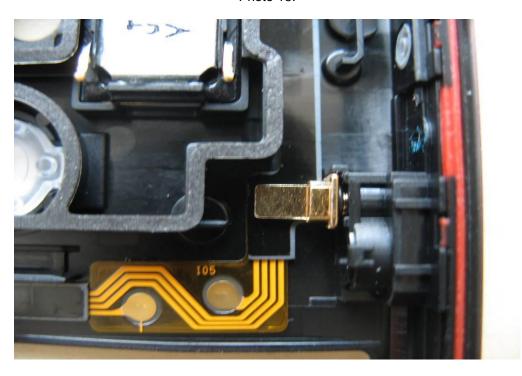
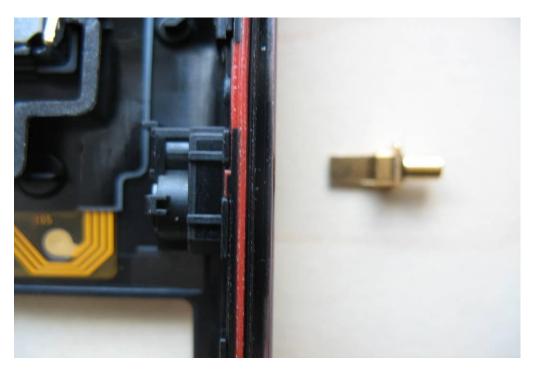


Photo 16:



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Photo 17:



Photo 18:



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Photo 19:



Photo 20:



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Photo 21:

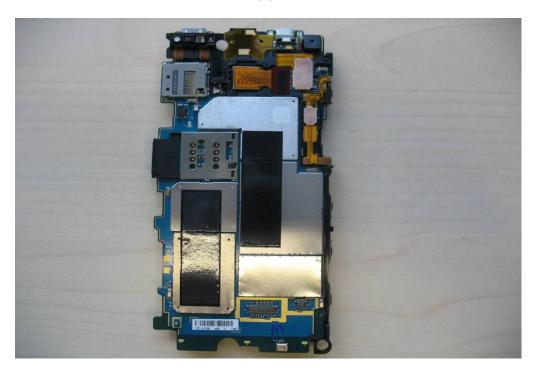
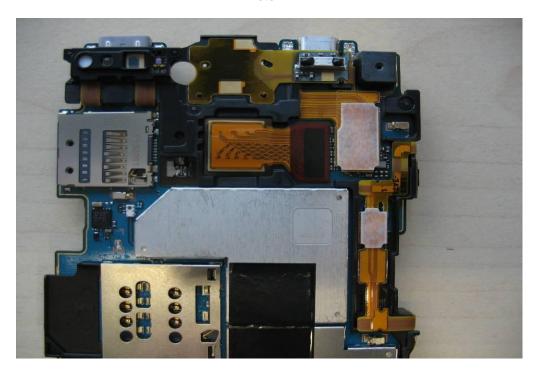


Photo 22:



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Photo 23:

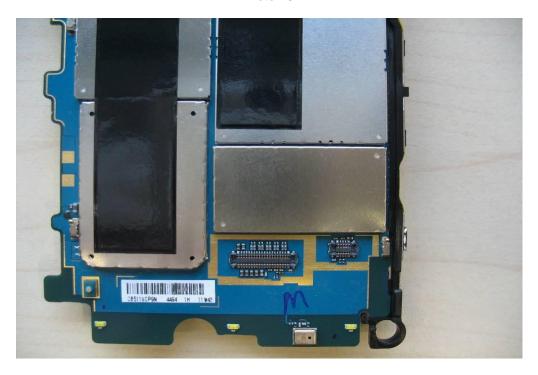
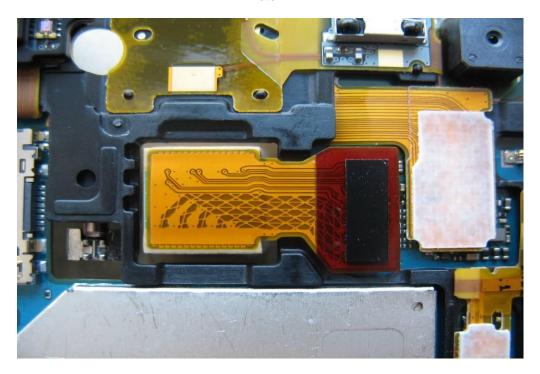


Photo 24:



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Photo 25:

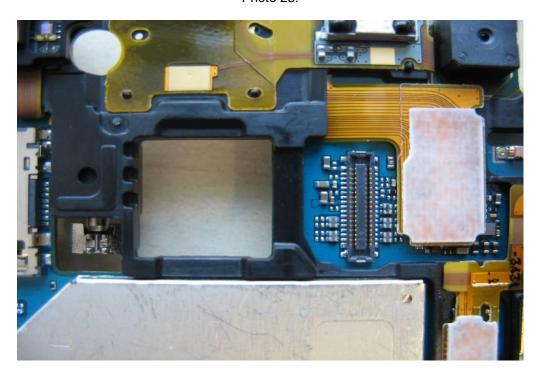
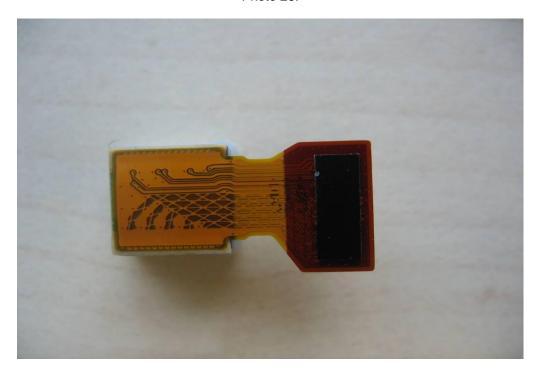


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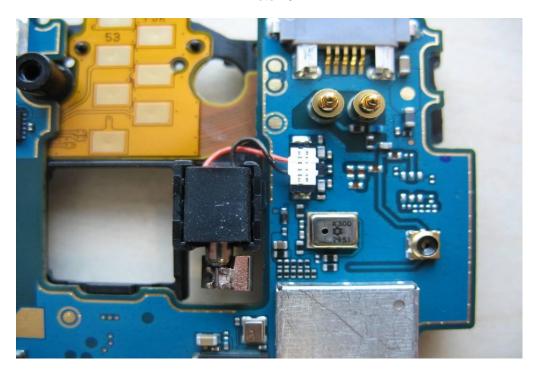
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Photo 27:



Photo 28:



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Photo 29:



Photo 30:



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Photo 31:



Photo 32:



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Photo 33:

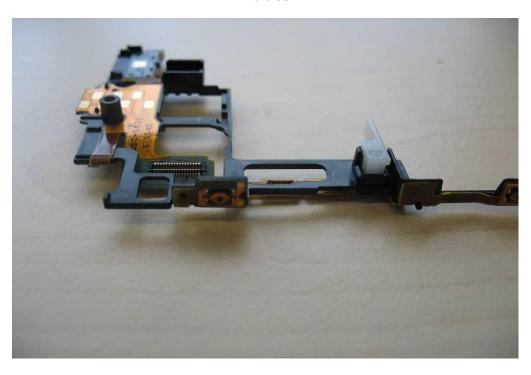


Photo 34:



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Photo 35:



Photo 36:



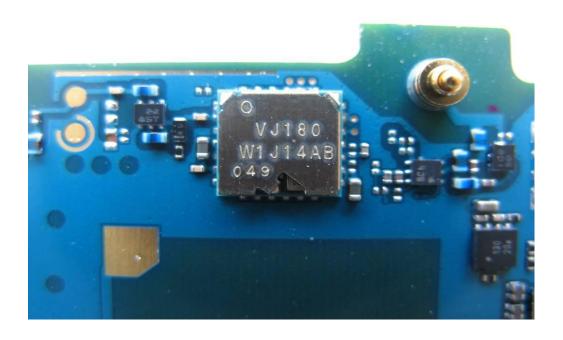
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Photo 37:



Photo 38:



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Photo 39:

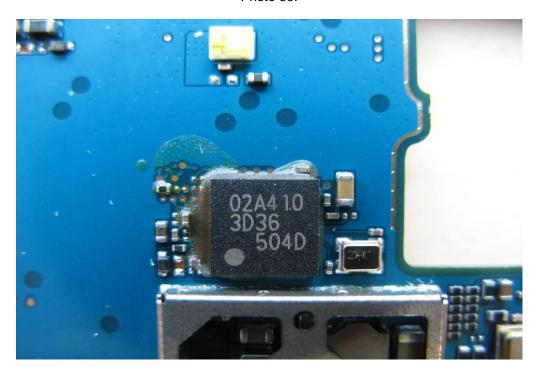
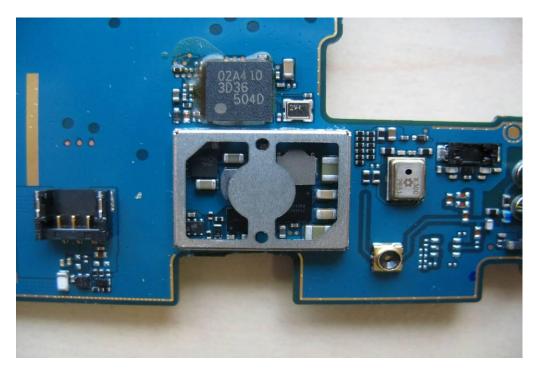


Photo 40:



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Photo 41:

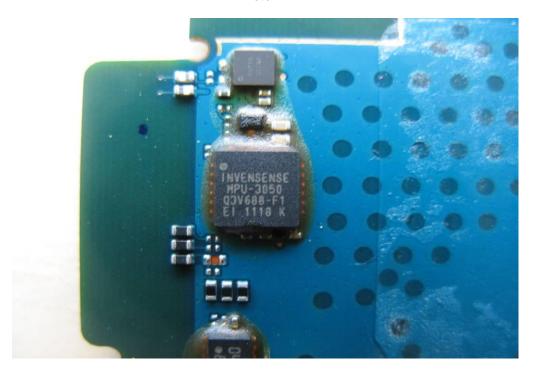


Photo 42:



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Photo 43:

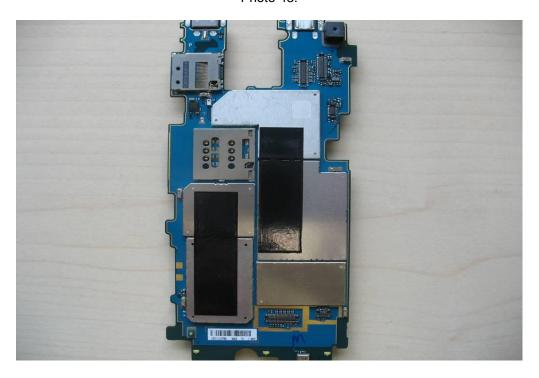
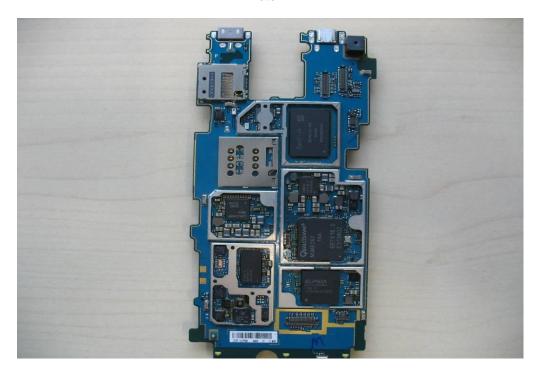


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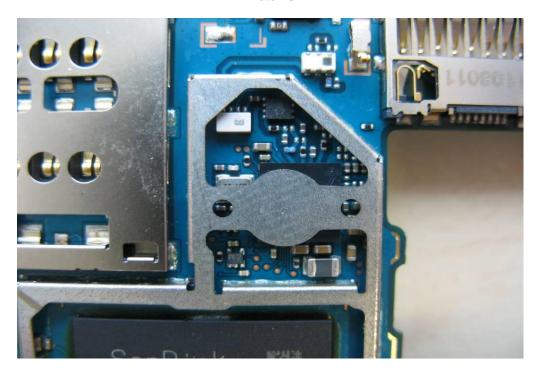
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Photo 45:



Photo 46:



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Photo 47:

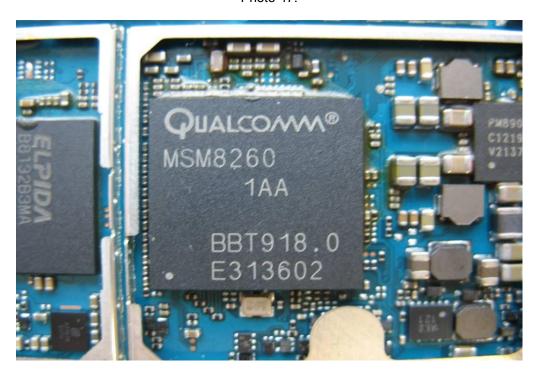
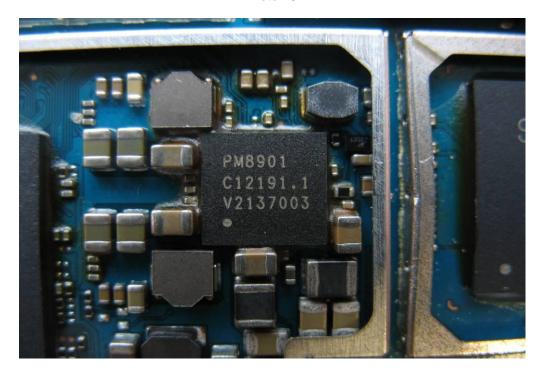


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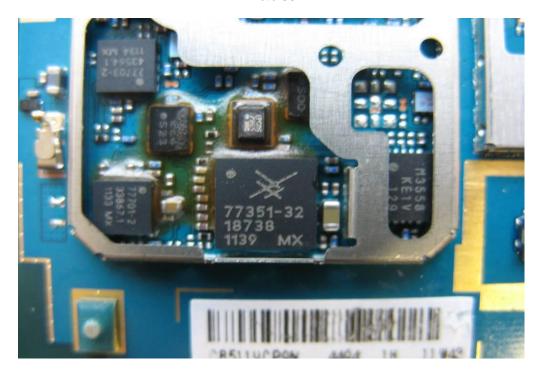
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Photo 49:



Photo 50:



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Photo 51:

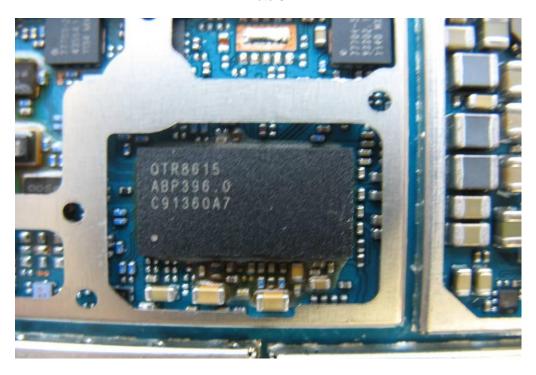


Photo 52:



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Annex D Document history

Version	Applied changes	Date of release
1.0	Initial release	2012-01-06
-A	New clause added	2012-01-30
-B	Measurement distance corrected at page 8	2012-02-03

Annex E Further information

Glossary

AVG - Average

DUT - Device under test

EMC - Electromagnetic Compatibility

EN - European Standard EUT - Equipment under test

ETSI - European Telecommunications Standard Institute

FCC - Federal Communication Commission

FCC ID - Company Identifier at FCC

HW - Hardware

IC - Industry Canada
Inv. No. - Inventory number
N/A - Not applicable
PP - Positive peak
QP - Quasi peak
S/N - Serial number
SW - Software

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Annex F Accreditation Certificate



Front side of certificate

Back side of certificate

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

http://www.cetecom.com/fileadmin/de/CETECOM_D_Saarbruecken/accreditations_Jan_2010/DAKKS_Akkredi_Urk_EN17025-En_incl_Annex.pdf

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